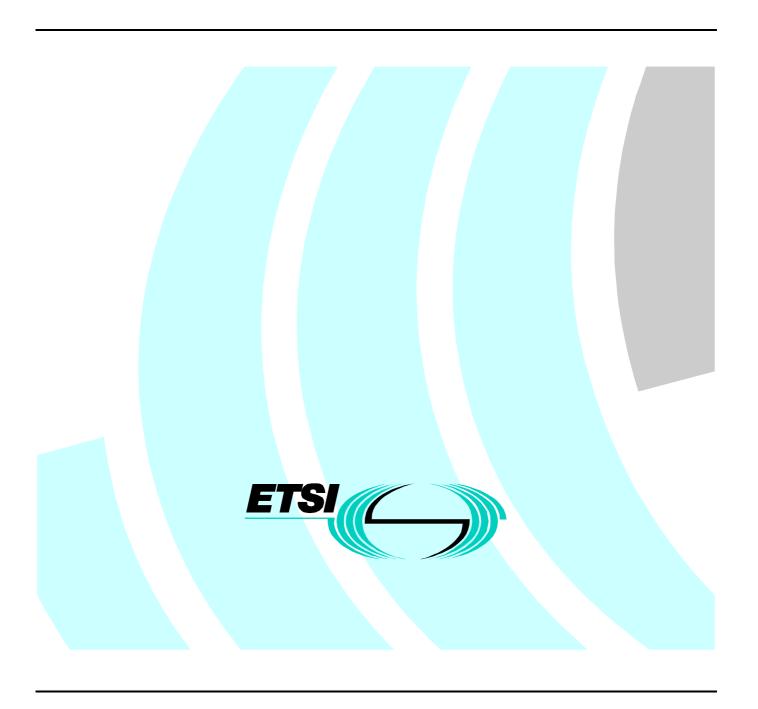
ETSI EN 300 394-4-4 V1.1.1 (2001-01)

European Standard (Telecommunications series)

Terrestrial Trunked Radio (TETRA);
Conformance testing specification;
Part 4: Protocol testing specification for
Direct Mode Operation (DMO);
Sub-part 4: Test Suite Structure and Test Purposes (TSS&TP)
for Direct Mode Repeater (DM-REP) type 1



Reference

DEN/TETRA-02009-4-4

Keywords

DMO, protocol, radio, testing, TETRA, TSS&TP, TTCN

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Foreword

This European Standard (Telecommunications series) has been produced by ETSI Project Terrestrial Trunked Radio (TETRA).

The present document had been submitted to Public Enquiry as ETS 300 394-4-4. During the processing for Vote it was converted into an EN.

The present document is part 4 of a multi-part deliverable covering the Terrestrial Trunked Radio (TETRA); Conformance testing specification, as identified below:

Part 1: "Radio";

Part 2: "Protocol testing specification for Voice plus Data (V+D)";

Part 3: "Protocol testing specification for Packet Data Optimized (PDO)";

Part 4: "Protocol testing specification for Direct Mode Operation (DMO)";

Part 5: "Security".

National transposition dates	
Date of adoption of this EN:	22 December 2000
Date of latest announcement of this EN (doa):	31 March 2001
Date of latest publication of new National Standard or endorsement of this EN (dop/e):	30 September 2001
Date of withdrawal of any conflicting National Standard (dow):	30 September 2001

1 Scope

EN 300 394-4 contains the Test Suite Structure (TSS) and Test Purposes (TPs) to test the TETRA Direct Mode Operation (DMO) protocols. EN 300 394-4 is divided into several parts, each one dealing with a different set of layer 3 and layer 2 DMO protocols. The present document deals with TSS&TP for Direct Mode Repeater type 1 (DM-REP1) Air Interface protocol, data link layer 2 only, while sub-part 1 deals with TSS&TP for DM MS to MS protocol and sub-part 3 deals with DM-MS operating through Repeater type 1 (MS-REP1) Air Interface protocol

Testing of security features is outside the scope of the present document.

The objective of this test specification is to provide a basis for approval tests for TETRA equipment giving a high probability of air interface inter-operability between different manufacturer's TETRA equipment.

The ISO standard for the methodology of conformance testing, ISO/IEC 9646-1 [3] and ISO/IEC 9646-2 [4], as well as the ETSI methodology for conformance testing, ETS 300 406 [5], are used as the basis for the test methodology.

2 References

The following documents contain provisions which, through reference in this text, constitute provisions of the present document

- References are either specific (identified by date of publication, edition number, version number, etc.) or non-specific.
- For a specific reference, subsequent revisions do not apply.
- For a non-specific reference, the latest version applies.
- [1] ETSI EN 300 396-4: "Terrestrial Trunked Radio (TETRA); Technical requirements for Direct Mode Operation (DMO); Part 4: Type 1 repeater Air Interface".
- [2] ETSI EN 300 396-8-2: "TETRA; Direct Mode Operation (DMO); Part 8: Protocol Implementation Conformance Statement (PICS) proforma specification; Part 8-2: Type 1 repeater Air Interface".
- [3] ISO/IEC 9646-1 (1995): "Information technology Open Systems Interconnection Conformance Testing Methodology and Framework Part 1: General Concepts". (See also ITU-T Recommendation X.290).
- [4] ISO/IEC 9646-2 (1995): "Information technology Open Systems Interconnection Conformance Testing Methodology and Framework Part 2: Abstract Test Suite Specification". (See also ITU-T Recommendation X.291).
- [5] ETSI ETS 300 406 (1995): "Methods for Testing and Specification (MTS); Protocol and profile conformance testing specifications; Standardization methodology".

3 Definitions and abbreviations

3.1 TETRA definitions

For the purposes of the present document, the terms and definitions given in EN 300 396-4 [1] apply.

3.2 TETRA abbreviations

For the purposes of the present document, the following abbreviations apply:

CM Circuit Mode

DMCC Direct Mode Call Control
DMO Direct Mode of Operation
FCS Frame Check Sequence

ITSI Individual TETRA Subscriber Identity

MAC Medium Access Control MNI Mobile Network Identity

MS Mobile Station

NWK Network. Layer 3 of the TETRA protocol stack

RX Receiver

SDS Short Data Services SDU Service Data Unit TX Transmitter

3.3 ISO 9646 abbreviations

For the purposes of the present document the following ISO/IEC 9646-1 [3] abbreviations apply:

IUT Implementation Under Test

IXIT Implementation eXtra Information for Testing

PDU Protocol Data Unit

PICS Protocol Implementation Conformance Statement
PIXIT Protocol Implementation eXtra Information for Testing

TP Test Purpose
TSS Test Suite Structure

4 Test Suite Structure (TSS)

4.1 MAC layer test groups

The first level of the MAC test groups separates the MAC test suite in functional test groups: CA, BV and TI.

The following list defines the MAC layer test group names and identifiers:

- DM-REP1 MAC layer (DMO_DMREP1_MAC)
 - Capability tests (CA)
 - Valid behaviour tests (BV)
 - Invalid behaviour tests (BI)
 - Timer tests (TI)

4.2 Test group description

Capability (CA) tests provide limited testing that the observable capabilities of the IUT are in accordance with the conformance requirements and the additional capabilities claimed in the PICS/PIXIT.

The Valid Behaviour (BV) group tests an IUT in response to valid behaviour of the test system. "Valid" means that a test event is syntactically and contextually correct. All test cases in the valid behaviour group are intended to verify as thoroughly as possible the various functions of the protocol.

Different timers are defined to supervise the various state transitions. The Timer (TI) test group is intended to verify that the IUT is reacting properly to an expiry of one of the timers or to a counter mismatch.

5 Introduction to Test Purposes (TPs)

The test purposes are defined in clause 6 of the present document for MAC layer.

5.1 Test purpose definition conventions

Each TP is described using text presented in a table.

The table contains the following information:

Table 1

TP-Name		Requirement ref: reference to the paragraph number of
The TP name is a unique identifier, specified		specification EN 300 396-4 [1] stating this conformance
according to the TP na		requirement.
defined in clause 5.2.	(It is also the name of	For example: EN 300 396-4 [1], 6.2.5.1.
the corresponding test	t case).	
Purpose	Purpose of the test itself,	indicating for example the test performed against a requirement
	of the protocol, described	
	Example: test of changed	over initiated from RX reservation state.
Selection cond	Expression based on EN	300 396-8-2 [2] PICS statements, used to select or deselect the
	corresponding test case	according to the options of the implementation.
Test description	Body of the test.	
Pass criteria	Visible action to be obse	rved at PCO to declare that the IUT passes the test and conforms
	to the specifications.	
Preamble	"None" or name of the pr	eamble procedure bringing the IUT from idle state to the state
	required to run the test.	
Postamble	"None" or name of the po	ostamble to bring the IUT back to idle state.

5.2 Test purpose naming conventions

The identifier of a test purpose is built according to table 2:

Table 2: Test purpose naming convention

DMO/ <ts>/<tt>/<ss>/<nn></nn></ss></tt></ts>		
<ts> = test suite type</ts>	DMREP1	DM Repeater type 1
tt = Type of testing	CA BV BI TI	Capability Tests Valid Behaviour Tests Invalid Behaviour Tests Timer expiry and counter mismatch tests
<nn> = sequential number</nn>	01-99	Test Purpose Number

5.3 Selection expressions

A test case, based on a test purpose described here, can be selected or deselected from the test suite, according to the evaluation of selection expressions which reflect the capabilities supported or not by the implementation under test.

6 DM-REP1 test purposes

In this test purpose description, the following test configuration is defined: the IUT is a DM-REP1. The main tester is a MS connected to a Repeater type 1 (MS-REP1) and it plays the role of the master of the call. A parallel tester plays the role of the slave. Most of the tests verify that the repeater re-transmits properly what is received from the main tester to the parallel tester, and from the parallel tester to the main one.

6.1 DM-REP1 MAC layer

6.1.1 DM-REP1 MAC capability tests

Test group objective: To test MAC basic capability

fill bit mechanism.

DMO_MSREP1_MAC_CA_01	Reference: EN 300 396-4 [1], 9.5.3.2		
Purpose	Fill bit addition and deletion mechanism.		
Test description	The main tester initiates a CM or SDS call according to IUT capabilities, by transmitting to the IUT a DMAC-SYNC PDU containing the appropriate PDU.		
Pass criteria	Check that the IUT re-transmits the DMAC-SYNC PDU containing identical PDU to the parallel tester, meaning that the IUT fill bit deletion and addition mechanism works properly.		
Selection EN 300 396-8-2 [2]	A.32/1 IUT supports circuit mode call; or A.32/2 IUT supports Short Data Services.		
Preamble	None.		
Postamble	Free DM channel.		

Presence signal

DMO_MSREP1_MAC_CA	A_02 Reference: EN 300 396-4 [1], 9.4.5.1
Purpose	Check sending of presence signal.
Test description	The main tester is connected to the DM REP1 and the DM channel is free.
	Check that the IUT sends at irregular intervals between DT253 and DT254 time a DPRES-SYNC PDU, in the DSB, in all four slots of DN253 consecutive frames.
Selection	A.40/2 IUT sends DPRES-SYNC.
EN 300 396-8-2 [2]	
Preamble	None.
Postamble	None.

6.1.2 DM-REP1 MAC valid behaviour tests

DMO_DMREP1_MAC_BV	/_01 Reference: EN 300 396-4 [1], 9.4.2.2.3, 9.5.1.1.1		
Purpose	Check DM-REP channel surveillance when idle at DM-MS call set-up; Check		
	retransmission of signalling message received from master DM-MS.		
Test description	The tester initiates a CM or SDS call, according to IUT capabilities. It translates into a		
	DMAC_SYNC PDU with master/slave link flag set to 1, communication type		
	element=01, 10 bit repeater address.		
	Verify that the IUT accepts the call and re-transmits the signalling information (It		
	retransmits the DMAC-SYNC PDU containing the DM-SETUP or DM-SETUP PRES		
	or DM-SDS DATA or DM-SDS UDATA SDU, with master/slave link flag set to 0).		
Selection	A.32/1 IUT supports circuit mode call;		
EN 300 396-8-2 [2]	or		
	A.32/2 IUT supports Short Data Services.		
Preamble	None.		
Postamble	Free DM channel.		

DMO_DMREP1_MAC_B\	/_02 Reference: EN 300 396-4 [1], 9.5.2.1		
Purpose	Check retransmission of signalling message received from a slave DM-MS.		
The main tester initiates a DM-SETUP PRES which is re-transmitted by the IUT to parallel tester. The parallel tester answers with DM-CONNECT contained in a DMAC-SYNC with master/slave link flag set to 0, communication type 01, its own bit repeater address.			
Pass criteria	Verify that the IUT re-transmits to the main tester the DMAC-SYNC containing DM-CONNECT where master/slave flag is set to 1.		
Selection EN 300 396-8-2 [2]	A.32/1 IUT supports circuit mode call.		
Preamble	None.		
Postamble	Free DM channel.		

DMO_DMREP1_MAC_B\	Reference: EN 300 396-4 [1], 9.4.4.1, 9.6.2.2
Purpose	Check DM-REP procedure: set up with presence check.
Test description	The main tester initiates a DM-SETUP PRES which is re-transmitted by the IUT to the
	parallel tester. The parallel tester answers with DM-CONNECT.
Pass criteria	Verify that the IUT re-transmits the DM-CONNECT to the main tester.
Selection	A.32/1 IUT supports circuit mode call.
EN 300 396-8-2 [2]	
Preamble	None.
Postamble	Free DM channel.

DMO_DMREP1_MAC_BV	/_04 Reference: EN 300 396-4 [1], 9.4.4.1, 9.6.2.2
Purpose	Check DM-REP procedure: set up with presence check.
_	The main tester initiates a DM-SETUP PRES which is re-transmitted by the IUT to the parallel tester. The parallel tester answers with DM-DISCONNECT.
Pass criteria	Verify that the IUT re-transmits the DM-DISCONNECT to the main tester.
Selection EN 300 396-8-2 [2]	A.32/1 IUT supports circuit mode call.
Preamble	None.
Postamble	Free DM channel.

DMO_DMREP1_MAC_BV	Reference: EN 300 396-4 [1], 9.4.4.1, 9.6.2.2
Purpose	Check DM-REP procedure: set up with presence check.
-	The main tester initiates a DM-SETUP PRES which is re-transmitted by the IUT to the parallel tester. The parallel tester answers with DM-CONNECT. The IUT re-transmits the DM-CONNECT to the main tester, which issues a DM-CONNECT ACK.
	Verify that the IUT re-transmits DM-CONNECT ACK to the parallel tester and then retransmits the traffic.
Selection EN 300 396-8-2 [2]	A.32/1 IUT supports circuit mode call.
Preamble	None.
Postamble	Free DM channel.

DMO_DMREP1_MAC_BV	Reference: EN 300 396-4 [1], 9.4.4.1, 9.6.2.2
Purpose	Check DM-REP procedure: set up with presence check.
	The main tester initiates a DM-SETUP PRES which is re-transmitted by the IUT to the parallel tester. The parallel tester answers with DM-CONNECT. The IUT re-transmits the DM-CONNECT to the main tester, which issues a DM-RELEASE.
	Verify that the IUT re-transmits DM-RELEASE to the parallel tester and then returns the channel to idle.
Selection EN 300 396-8-2 [2]	A.32/1 IUT supports circuit mode call.
Preamble	None.
Postamble	None.

DMO_DMREP1_MAC_BV	Reference: EN 300 396-4 [1], 9.5.1.1.2, 9.6.2.1		
Purpose	Re-transmission procedure: set up without presence check.		
	The main tester initiates a DM-SETUP which is re-transmitted by the IUT to the parallel tester.		
	Verify that the IUT re-transmits the DM-SETUP to the parallel tester in all four slots of DN232 frames.		
Selection	A.32/1 IUT supports circuit mode call.		
EN 300 396-8-2 [2]			
Preamble	None.		
Postamble	Free DM channel.		

DMO_DMREP1_MAC_E	Reference: EN 300 396-4 [1], 9.5.1.1.3		
Purpose	Re-transmission procedure: DM_SDS DATA or DM_SDS UDATA.		
Test description	The main tester initiates a DM_SDS DATA or DM_SDS UDATA which is re-transmitted by the IUT to the parallel tester.		
Pass criteria	Verify that the IUT re-transmits the DM_SDS DATA or DM_SDS UDATA to the parallel tester in all four slots of DN233 frames.		
Selection EN 300 396-8-2 [2]	A.32/2 IUT supports Short Data Services.		
Preamble	None.		
Postamble	None.		

DMO_DMREP1_MAC_BV	/_09 Reference: EN 300 396-4 [1], 9.5.1.1.3		
	Fragmentation.		
	The main tester initiates a SDS by transmitting DM-SDS DATA or DM-SDS UDATA PDU with data type 2, 3 or 4 in order to generate a fragmented message.		
	check that the parallel tester receives from the IUT: DMAC-SYNC with Fragmentation flag set to value 1, followed by n times DMAC-FRAG then ending with DMAC-END.		
Selection	A.32/2 Short Data Service (SDS).		
EN 300 396-8-2 [2]			
Preamble	None.		
Postamble	None.		

DMO_DMREP1_MAC_B\	/_10 Reference: EN 300 396-4 [1], 9.5.1.1.4		
Purpose	retransmission of message.		
Test description	The main tester initiates a command such as DM-CONNECT.		
Pass criteria	check that the IUT re-transmits the DMAC_SYNC PDU containing this command without changing slot, frame numbers and frame countdown, only the master/slave link flag is changed to 0.		
Selection	None.		
Preamble	None.		
Postamble	None.		

6.1.3 DM-REP MAC invalid behaviour tests

DMO_DMREP1_MAC_BI_01 Reference: EN 300 396-4 [1], 9.4.2.2.1, 9.4.2.2.3			
Purpose	Check DM-REP channel surveillance when idle at DM-MS call set-up, wrong address.		
Test description	The tester initiates a CM or SDS call, according to IUT capabilities, but not containing		
	the 10-bit repeater address.		
Pass criteria	Verify that the IUT ignores the call and does not re-transmit the signalling information		
	to the parallel tester.		
Selection	A.32/1 IUT supports circuit mode call;		
EN 300 396-8-2 [2]	or		
	A.32/2 IUT supports Short Data Services.		
Preamble	None.		
Postamble	Free DM channel.		

DMO_DMREP1_MAC_BI	O2 Reference: EN 300 396-4 [1], 9.5.2.1		
Purpose	Check absence of retransmission of signalling message received from a slave		
	DM-MS, if wrong address.		
Test description	The main tester initiates a DM-SETUP PRES which is re-transmitted by the IUT to the		
	parallel tester. The parallel tester answers with DM-CONNECT contained in a DMAC-SYNC with master/slave link flag set to 0, communication type 01, BUT		
	without its own 10 bit repeater address.		
Pass criteria	Verify that the IUT does not re-transmit the DMAC-SYNC where master/slave flag is set to 1 to the main tester.		
Selection EN 300 396-8-2 [2]	A.32/1 IUT supports circuit mode call.		
Preamble	None.		
Postamble	Free DM channel.		

6.1.4 DM-REP MAC timer tests

DMO_DMREP1_MAC_TI	_ 01 Reference: EN 300 396-4 [1], 9.4.2.3, 9.6.2.3		
Purpose	Check DM-REP channel surveillance when active during a call.		
Test description	The tester initiates a CM or SDS call, according to IUT capabilities, but does not send		
	DM-OCCUPIED within time DT256.		
Pass criteria	Verify that the IUT assumes the call is lost and returns to idle.		
Selection	A.32/1 IUT supports circuit mode call;		
EN 300 396-8-2 [2]	or		
	A.32/2 IUT supports Short Data Services.		
Preamble	None.		
Postamble	None.		

DMO_DMREP1_MAC_TI	DMREP1_MAC_TI_02 Reference: EN 300 396-4 [1], 9.4.2.3		
Purpose	Check DM-REP channel surveillance when active during a call.		
Test description	The tester issues channel reservation signalling not addressed to the DM-REP to make the channel appear RESERVED (see 9.4.2.1), but does not send DM-RESERVED within time DT258.		
Pass criteria	Verify that the IUT assumes the call is lost and returns to idle.		
Selection	None.		
Preamble	None.		
Postamble	None.		

DMO_DMREP1_MAC_TI	O3 Reference: EN 300 396-4 [1], 9.6.2.2		
Purpose	Check DM-REP procedure: set up with presence check, DT250 timer.		
	The main tester initiates a DM-SETUP PRES which is re-transmitted by the IUT to the parallel tester. The parallel tester answers with DM-CONNECT. The IUT re-transmits the DM-CONNECT to the main tester, which does not issue a DM-CONNECT ACK within DT250 after transmission of DM_SETUP PRES.		
Pass criteria	Verify that the IUT returns to idle as it assumes that the call failed.		
Selection	A.32/1 IUT supports circuit mode call.		
EN 300 396-8-2 [2]			
Preamble	None.		
Postamble	None.		

Bibliography

The following material, though not specifically referenced in the body of the present document (or not publicly available), gives supporting information.

ETS 300 396-1: "Terrestrial Trunked Radio (TETRA); Technical requirements for Direct Mode Operation (DMO); Part 1: General network design".

History

Document history				
Edition 1	October 1999	Public Enquiry	PE 200007: 1999-10-20 to 2000-02-18	
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